

Notice of References Cited	Application/Control No. 10/523,600	Applicant(s)/Patent Under Reexamination ZAJBER ET AL.	
	Examiner Len Tran	Art Unit 1725	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,102,101	08-2000	Hanazaki et al.	164/452
*	B	US-6,386,268	05-2002	Weyer et al.	164/454
*	C	US-2003/0178171	09-2003	Weyer et al.	164/442
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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